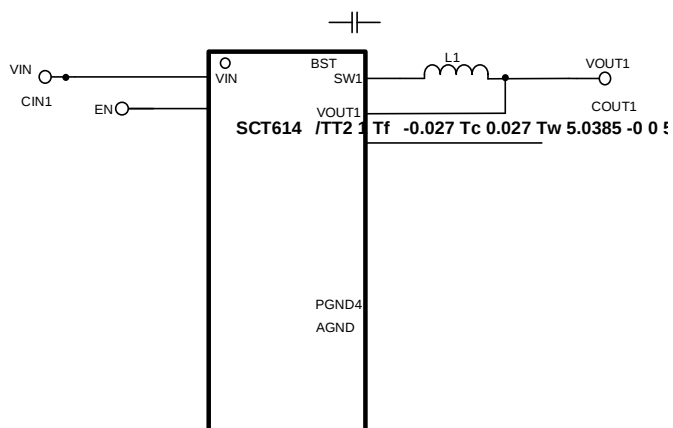


- Qualified for Automotive Applications
- AEC-Q100 Qualified with the Following Results:
 - Device Temperature Grade 1
- Wide Input Voltage Range: 3.5V-36V
- One Synchronous HV Buck Converter VOUT1:
 - Up to 3A Continuous Output Current
 - Output Voltage of 3.3/3.7/4.6/5V
- Dual Synchronous LV Buck Converters VOUT2, VOUT3:
 - Up to 2A Continuous Output Current
 - Output Voltage Range 0.8V to 2.35V with 50mV Steps
- One Low-Drop Regulator(LDO) VOUT4:
 - Up to 400mA Continuous Output Current
 - Output Voltage: 1.8/2.7/2.8/2.9/3.3V
- +/- 1.5% Feedback Reference Voltage
- Fixed 2.2MHz Switching Frequency with Integrated Frequency Dither for EMI Mitigation
- FCCM/PFM Selectable
- Programmable Power Sequencer for VOUT2, VOUT3 and VOUT4
- RESETB Output for System Management
- External Clock Synchronization
- Simple/QA Watchdog
- Integrated Protection Features:
 - Hiccup Over Current Protection
 - Output Over-voltage/Under-voltage Protection
 - Adjustable Input Voltage Under-voltage Lockout
 - Thermal Shutdown Protection
- Functional Safety Features:
 - Compliance with ISO26262 Development
 - Hardware Integrity up to Support ASIL-B System
 - ASIL-B Device Certification by TUV
 - BIST
- Up to 1MHz I2C Interface with Optional Packet Error-Checking (PEC)
- Available in FCQFN-24 (4mm*4mm)

The SCT61441S device is a wide input power management IC with four channels output. The device is designed for automotive camera module.

The SCT61441S integrates one 3A HV Buck, two identical 2A LV Buck and a 400mA LDO. Each channel output is continuously monitored, any over-voltage/under-



NOTE: Page numbers for previous revisions may differ from page numbers in the current version

Revision 1.0: Released to Market

Revision 1.1: Add watchdog description, update thermal resistance, correct typo

Revision 1.2: Correct package marking, correct package description, add SS time limit in EC

PART NUMBER	PACKAGING TYPE	STANDARD PACK QTY	PACKAGE MARKING	PINS	PACKAGE DESCRIPTION	MSL
SCT61441S- xxxxFDAR	Tape & Reel	5000	1441S	24	FCQFN4x4-24L	1
SCT61441S- 0001FDAR	Tape & Reel	5000	1441S	24	FCQFN4x4-24L	1

1) "xxxx" is the specific suffix code for different configuration, contact SCT for details

PART NUMBER		SCT61441S-0001FDAR
REGISTER VALUE	CHIP_ID	41h
	CONFIG_T1	01h
	CONFIG_EN	2Dh
	CONFIG_PU1	02h
	CONFIG_PU2	12h
	VOUT1	5V
	VOUT2	06h (1.1V)
	VOUT3	0Eh (1.5V)
		0

Td (36E)-2.2

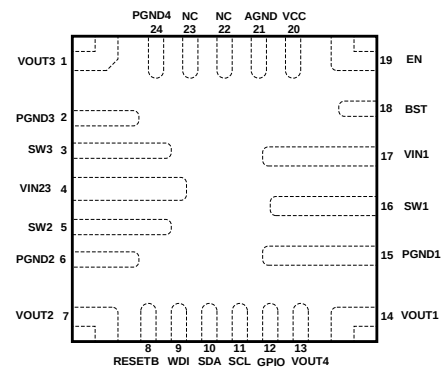
(h

2.835 0 Td (36206h)Tj ()Tj -0.002 T36

SCT61441S

Over operating free-air temperature unless otherwise noted⁽¹⁾

DESCRIPTION	MIN	MAX	UNIT
VIN, EN	-0.3	42(46V trans 100ms)	V
SW1	-0.3(-1V trans 30ns)	42	V
BST-SW1	-0.3		



NAME	NO.	DESCRIPTION
VOUT1	14	Voltage sense for the output of Buck1. The device regulates VOUT1 voltage to the setting value. The device regulates VOUT1 voltage to the value of 3.3V typical. Connect this pin to HV Buck1 output voltage via short trace.
PGND1	15	Power ground pin of HV Buck1.
SW1	16	Regulator switching node of HV Buck1. Connect SW1 to an external power inductor.
VIN	17	Input supply voltage. Connect a local bypass capacitor from VIN pin to GND pin. Path from VIN pin to high frequency bypass capacitor and GND must be as short as possible.
BST	18	Power supply bias for high-side power MOSFET gate driver of Buck1. Connect a 0.1uF capacitor from BST pin to SW pin. Bootstrap capacitor is charged when low-side power MOSFET is on or SW voltage is low.
EN	19	Enable pin. All four outputs will be activated once voltage upon EN reaches high threshold. The input voltage lockout threshold can be adjusted by connecting this pin to the input voltage through a resistor divider. The EN pin is internally pulled-down through 2.1M resistor. Connect to VIN pin if not used.
VCC	20	Output of the internal VCC regulator. Connect a ceramic bypass capacitor from this pin to PGND.
AGND	21	Analog ground pin of device. Connect this pin to power ground directly.
NC	22, 23	Not connected. Connect NC pins to ground.
PGND4	24	Power ground pin. Connect this pin to other PGND pins.

SCT61441S

Over operating free-air temperature range unless otherwise noted

PARAMETER	DEFINITION	MIN	MAX	UNIT
V _{IN}	Input voltage range	3.5	36	V
V _{OUT2}	LV Buck2 output voltage range	0.8	2.35	V
V _{OUT3}	LV Buck3 output voltage range	0.8	2.35	V
V _{OUT4}	LDO output voltage range	1.8	3.3	V
T _J	Operating junction temperature	-40	150	°C

PARAMETER	DEFINITION	MIN	MAX	UNIT
V _{ESD}	Human Body Model(HBM), per AEC-Q100-002	-2	+2	kV
	Charged Device Model(CDM), per AEC-Q100-011	-1	+1	kV

PARAMETER	THERMAL METRIC	FCQFN-24	UNIT
R	Junction to ambient thermal resistance ⁽¹⁾	39.68	°C/W
J _T	Junction-to-top characterization parameter	1.78	
J _B	Junction-to-board characterization parameter ⁽¹⁾	3.26	
R _(top)	Junction to case (top) thermal resistance ⁽¹⁾	24.67	
R _B	Junction to board thermal resistance ⁽¹⁾	3.46	

(1) SCT provides R_{JT} and R_{JB} numbers only as reference to estimate junction temperatures of the devices. R_{JT} and R_{JB} are not a characteristic of package itself, but of many other system level characteristics such as the design and layout of the printed circuit board (PCB) on which the SCT61441S is mounted, thermal pad size, and external environmental factors. The PCB board is a heat sink that is soldered to the leads and thermal pad of the SCT61441S. Changing the design or configuration of the PCB board changes the efficiency of the heat sink and therefore the actual R_{JT} and R_{JB}.

$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 150^{\circ}C$, typical values are tested under $25^{\circ}C$.

SYMBOL	PARAMETER	TEST CONDITION	MIN	TYP	MAX	UNIT
Power Supply and Output						
V_{IN}	Operating input voltage		3.5		36	V
$V_{IN_UVLO_RISING}$	Input UVLO rising threshold	$V_{IN_START}[1:0]=00b$	3	3.2	3.4	V
		$V_{IN_START}[1:0]=01b$	3.8	4	4.2	V
		$V_{IN_START}[1:0]=10b$	4.8	5	5.2	V
		$V_{IN_START}[1:0]=11b$	5.8	6	6.2	V
		$V_{IN_STOP}[1:0]=00b$	2.5	2.8	3.1	V
$V_{IN_UVLO_FALLING}$	Input UVLO falling threshold					

SCT61441S

$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 150^{\circ}C$, typical values are tested under $25^{\circ}C$.

SYMBOL	PARAMETER	TEST CONDITION	MIN	TYP	MAX	UNIT
$R_{DS(on)_H1}$	High-side MOSFET on-resistance	$V_{BOOT}-V_{SW}=5V$		75	150	m
$R_{DS(on)_L1}$	Low-side MOSFET on-resistance			50	120	m
I_{LIM_HS1}	High-side power MOSFET current limit		4.2	5.2	6.2	A
I_{LIM_LSP1}	Low-side power MOSFET positive current limit		3.2	4.2	5.2	A
I_{LIM_LSN1}	Low-side power MOSFET negative current limit		0.8	2	3.2	A
R_{DIS1}	Discharge resistance	Output disabled		100	200	
t_{ON_MIN1}	Minimum on-time			80		ns
Phase1 ⁽¹⁾	Switching phase			0		deg

VOUT2 (LV Buck)

$V_{S2}^{(1)}$	Supply voltage range		3		5.5	V
V_{ACC2}	Voltage accuracy	$T_J = 25^{\circ}C$	-1		1	%
		$T_J = -40^{\circ}C\sim 150^{\circ}C$	-1.5		1.5	%
$R_{DS(on)_H2}$	High-side MOSFET on-resistance			65	150	m
$R_{DS(on)_L2}$	Low-side MOSFET on-resistance			50	120	m
I_{LIM_HS2}	High-side power MOSFET current limit		2.8	3.6	4.4	A
I_{LIM_LSP2}	Low-side power MOSFET positive current limit		2.2	3.2	4.2	A
I_{LIM_LSN2}	Low-side power MOSFET negative current limit		1	2	3	A
R_{DIS2}	Discharge resistance	Output disabled		50	100	
t_{ON_MIN2}	Minimum on-time			90		ns
Phase2 ⁽¹⁾	Switching phase			0		deg

VOUT3 (LV Buck)

$V_{S3}^{(1)}$	Supply voltage range		3		5.5	V
V_{ACC3}	Voltage accuracy	$T_J = 25^{\circ}C$	-1		1	%
		$T_J = -40^{\circ}C\sim 150^{\circ}C$	-1.5		1.5	%
$R_{DS(on)_H3}$	High-side MOSFET on-resistance			65	150	m
$R_{DS(on)_L3}$	Low-side MOSFET on-resistance			50	120	m
I_{LIM_HS3}	High-side power MOSFET current limit		2.8	3.6	4.4	A
I_{LIM_LSP3}	Low-side power MOSFET positive current limit		2.2	3.2	4.2	A
I_{LIM_LSN3}	Low-side power MOSFET negative current limit		1	2	3	A

$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 150^{\circ}C$, typical values are tested under $25^{\circ}C$.

SYMBOL	PARAMETER	TEST CONDITION	MIN	TYP	MAX	UNIT
R_{DIS3}	Discharge resistance	Output disabled		55	100	
t_{ON_MIN3}	Minimum on-time			90		ns
$\varphi_{Phase3}^{(1)}$	Switching phase			180		deg

VOUT4 (LDO)

V_{ACC4}	Voltage accuracy	VOUT4 set to 2.8V	-1.5		1.5	%
V_{DROP_LDO}	LDO dropout voltage	VOUT1=3.3V, VOUT4=3.3V $I_{OUT4}=400mA$		120	300	mV
$L_{DO_LINE_REG}$	LDO line regulation	VOUT1=3.3V to 5V, VOUT4 set to 2.8V, $I_{OUT4}=100mA$		0.25		%/V
$L_{DO_LOAD_REG}$	LDO load regulation	VOUT1=3.3V, VOUT4 set to 2.8V, $I_{OUT4}=10mA$ to 400mA		0.05		%
$I_{LIM_LDO_OCP}$	LDO over current limit	VOUT1=3.3V, VOUT4 set to 2.8V	480	600	720	mA
$I_{LIM_LDO_SCP}$	LDO output short current limit	VOUT1=3.3V, VOUT4=0V		140		mA
R_{DIS4}	Discharge resistance	Output disabled		100	200	

Soft Start and Delay

T_{SS}	Soft-start time	SS=0 to 1.1V, option 0	0.5	1	1.5	ms
		SS=0 to 1.1V, option 1	0.2	0.5	0.8	ms
$T_{EN_ON}^{(1)}$	Device on time from EN high			2.8		ms
$T_{ON_DELAY2}^{(1)}$	On delay for VOUT2		0		75	ms
$T_{ON_DELAY3}^{(1)}$	On delay for VOUT3		0		75	ms
$T_{ON_DELAY4}^{(1)}$	On delay for VOUT4		0		75	ms

Switching Frequency

F_{SW}	LV Buck Switching frequency		1.98	2.2	2.42	MHz
F_{SW1}	HV Buck switching frequency	High frequency option	1.98	2.2	2.42	MHz
		Low frequency option	360	400	440	kHz
F_{FSS_PERIOD}	Frequency spread spectrum period	FSS_PERIOD[0]=0b		4.5		kHz
		FSS_PERIOD[0]=1b		10		

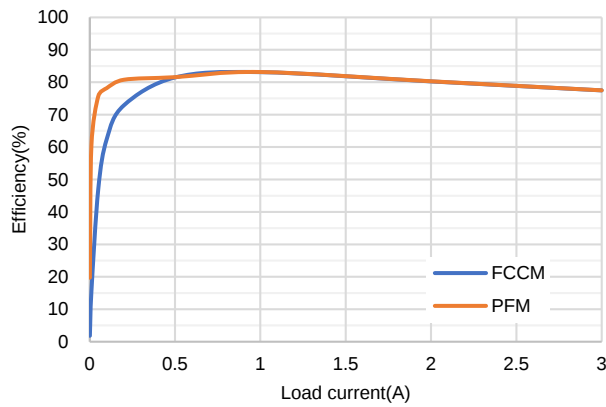
F_{FSS_RANGE} Frequency spread spectrum

SCT61441S

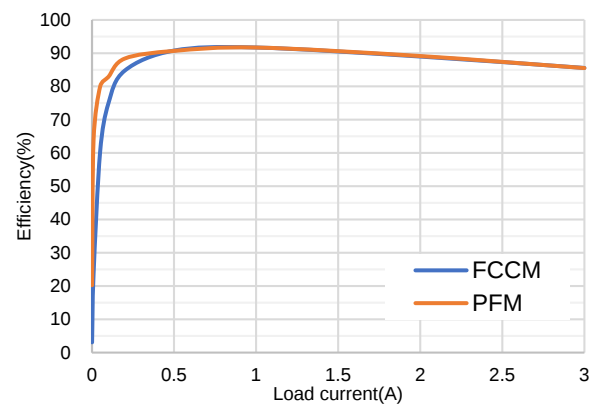
$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 150^{\circ}C$, typical values are tested under $25^{\circ}C$.

SYMBOL	PARAMETER	TEST CONDITION	MIN	TYP	MAX	UNIT
V_{OVTH}	Output over-voltage threshold for all outputs	PG1/2/3/4_SEL[1:0]=01, VOUT rising		S		

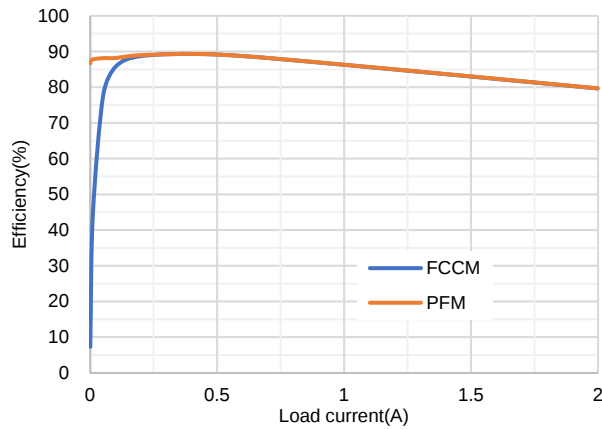
$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 125^{\circ}C$, unless otherwise noted.



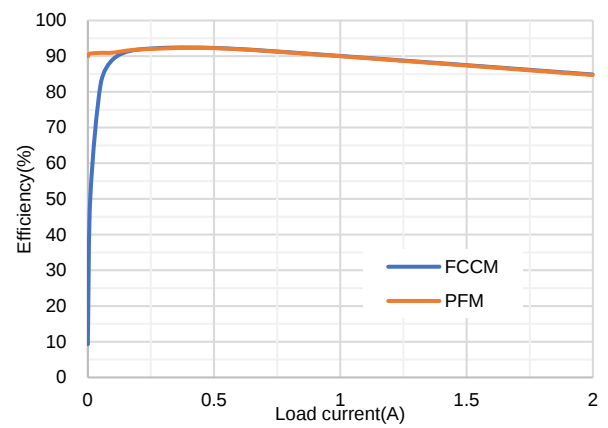
Buck1 Efficiency vs Load Current, $V_{OUT1}=3.3V$, $f_{SW1}=2.2MHz$



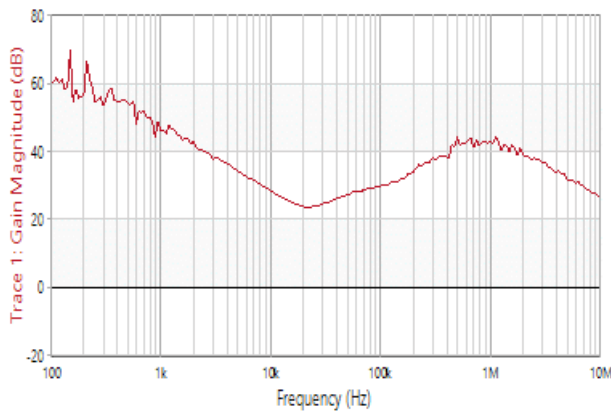
Buck1 Efficiency vs Load Current, $V_{OUT1}=3.3V$, $f_{SW1}=400kHz$



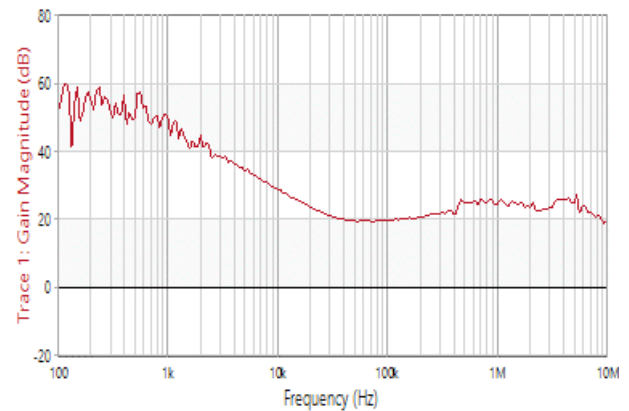
Buck2/3 Efficiency vs Load Current, $V_{OUT2/3}=1.2V$



Buck2/3 Efficiency vs Load Current, $V_{OUT2/3}=1.8V$

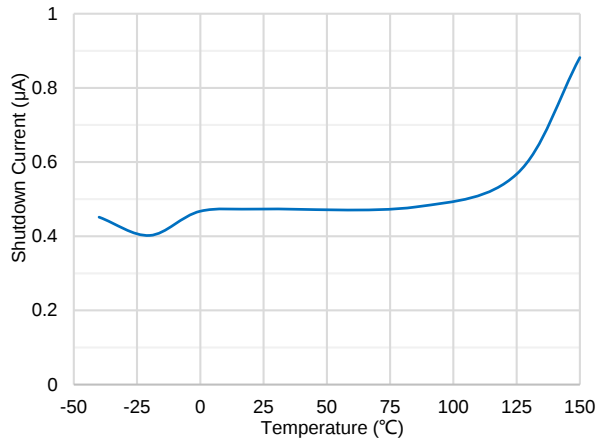


LDO PSRR, $V_{OUT4}=2.8V$, $I_{OUT4}=10mA$

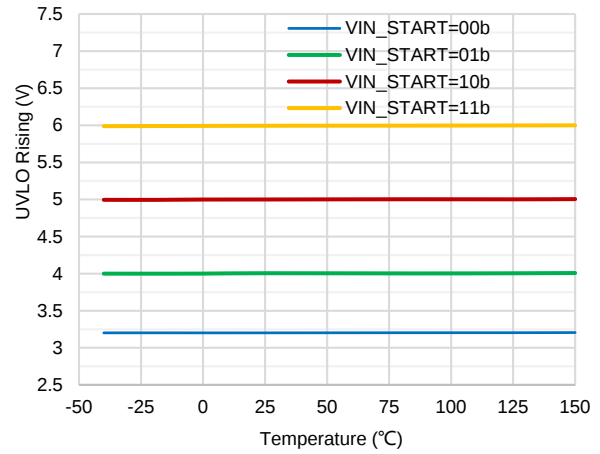


LDO PSRR, $V_{OUT4}=2.8V$, $I_{OUT4}=100mA$

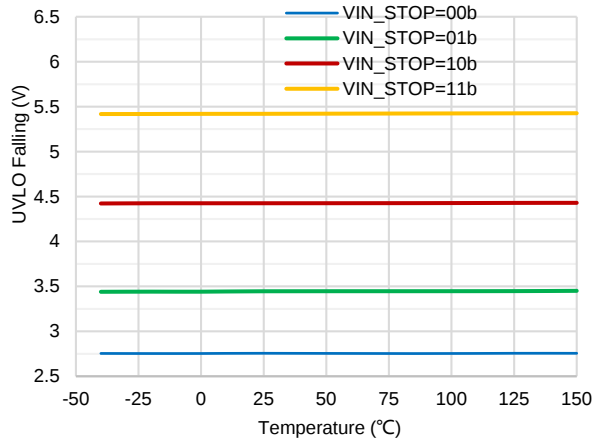
$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 125^{\circ}C$, unless otherwise noted.



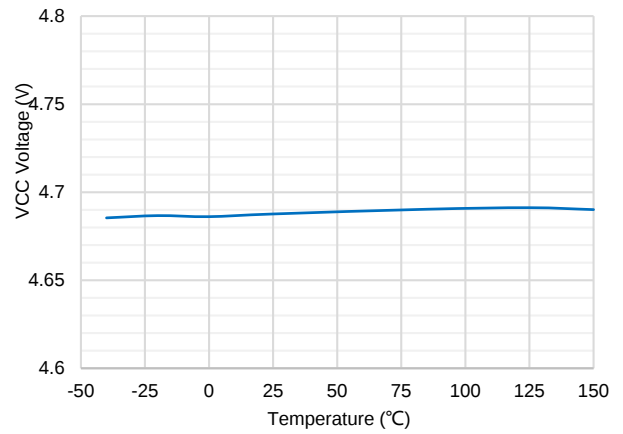
Shutdown Current vs. Temperature



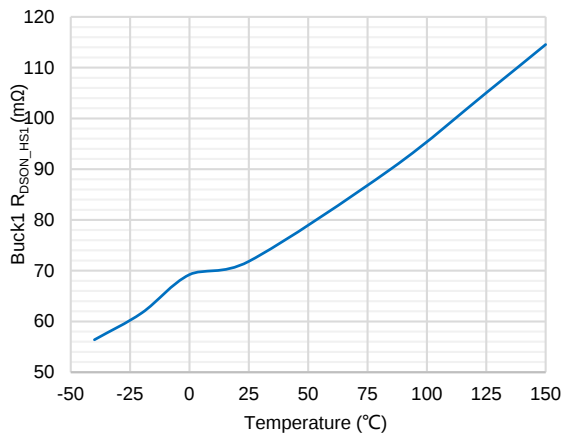
UVLO Rising Threshold vs. Temperature



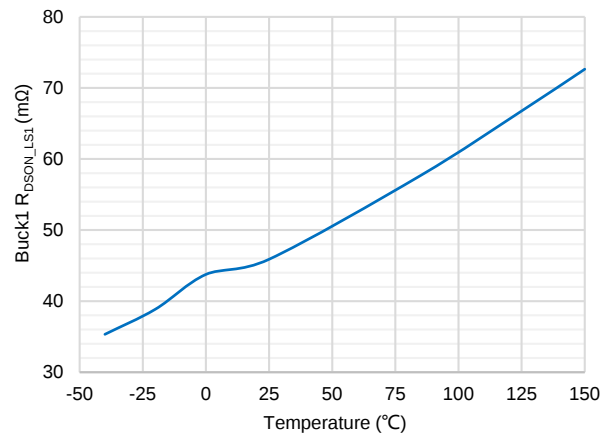
UVLO Falling Threshold vs. Temperature



VCC vs. Temperature

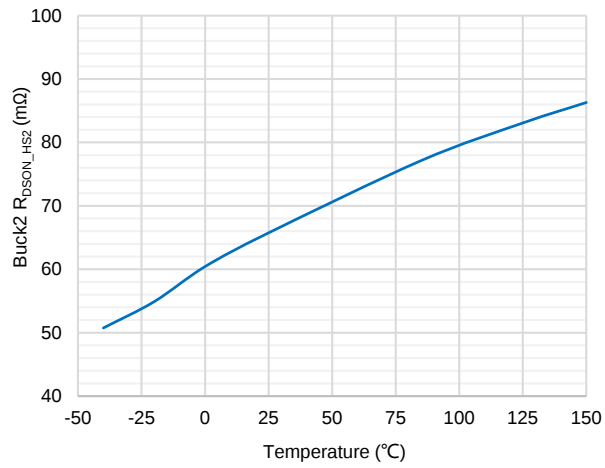


Buck1 R_{DS(on)_HS1} vs. Temperature

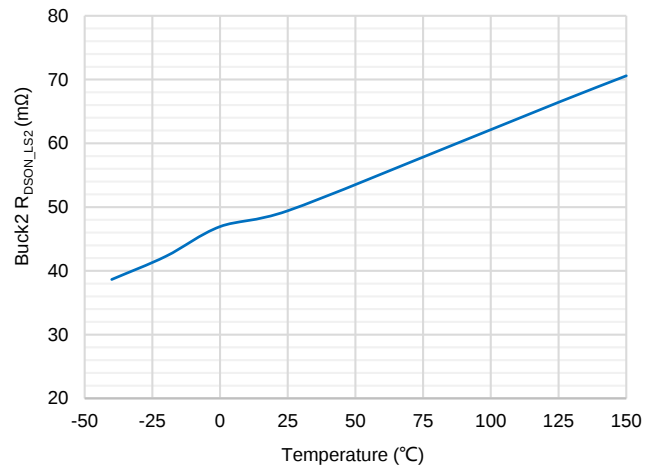


Buck1 R_{DS(on)_LS1} vs. Temperature

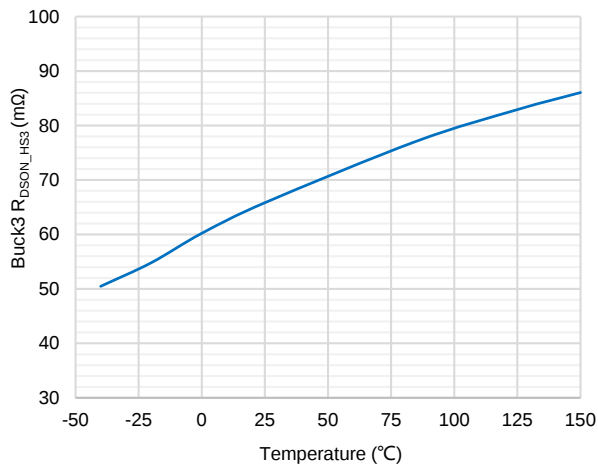
$V_{IN}=12V$, $T_J=-40^{\circ}C\sim 125^{\circ}C$, unless otherwise noted.



Buck2 R_{DSON_HS2} vs. Temperature



Buck2 R_{DSON_LS2} vs. Temperature



Buck3 R_{DSON_HS3} vs. Temperature

Buck3 R_{DSON_LS3} vs. Temperature

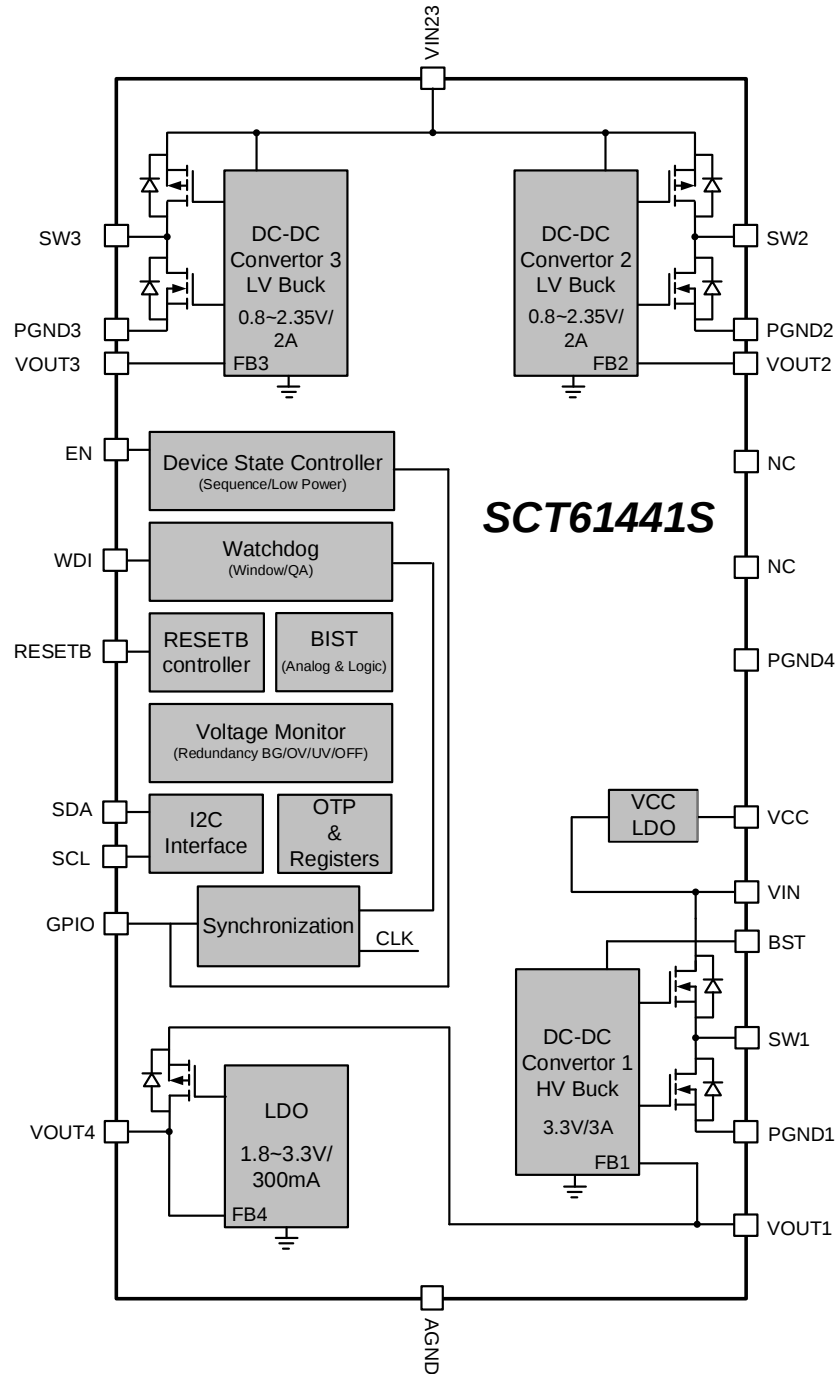


Figure 1.

Overview

The SCT61441S device is a wide input power management IC with quad channels output. The device is designed for camera modules in automotive ADAS vision and DMS/OMS applications. The SCT61441S integrates one 3A HV Buck, two identical 2A LV Buck and a 400mA LV Low-Drop Regulator(LDO). Each channel output is continuously monitored, any over-voltage/under-voltage fault will trigger RESETB pull low. Any deep over-voltage/under-voltage will be detected and the device will enter

Figure 2. Operating State Transitions

Table 1. State and Function Matrix Table

State	Function										
	I2C	OTP load	Register reset	HV BUCK1	LV BUCK2	LV BUCK3	LDO4	Watchdog	OCF	DOVP/DUVP detect	TSD
IDLE	OFF	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF
LOADOTP	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF
LBIST	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF
DEEPSAFE	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	ON
ABIST	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF	ON
POWERUP	ON	OFF	OFF	UP	UP	UP	UP	OFF	ON	ON	ON
NORMAL	ON	OFF	OFF	ON	ON	ON	ON	ON	ON	ON	ON
RESET	ON	OFF	OFF	ON	ON	ON	ON	OFF	ON	ON	ON

Table 2. State [()0.6 ()]TJ 0 Tc 0 T77.14 T68 (at)3.6 (e [()0.6 ()w Td (t)F (2)Tjun).52 (

- VIN/EN UVLO
- VCC OVP
- VIN OVP
- RESETB Stuck
- Loss of ground

ABIST State

To ensure safety mechanism work well, the device will check through all critical analog comparators before output start-up. If ABIST check is failed, the device will go back to DEEPSAFE state. ABIST will be implemented every time SCT61441S enter ABIST state, the device will transit to POWERUP state once ABIST is passed. Any ABIST failure will be recorded in register **SYS_STATE**.

POWERUP State

In POWERUP state, all rails will start-up following a dedicated sequence. Since the HV buck VOUT1 is the power supply for the other channels, VOUT1 is always set to start-up first. Then the other channels will rise after turn on delay time respectively. The turn on delay time for each is independent and can be adjusted via changing register **CONFIG_PU1** and **CONFIG_PU2**, thus flexible sequence is available. Deep OV/UV protection is activated to protect channels from destructive OV/UV risk. If all channels finish soft-start and they are within power good range, the RESETB rising timer begins. Once the timer is expired, the device will enter NORMAL state and RESETB will output high. If deep safe event occurs, the state will transit to DEEPSAFE state directly.

NORMAL State

The NORMAL state is the normal running of device with all outputs on. The RESETB pin is released after specific delay time upon entering this state. If watchdog is enabled by register **CONFIG_WD3**, watchdog window will start after setting delay time. The delay time is configured by **WD_1UD[2:0]** in register **CONFIG_WD3**. MCU should feed the watchdog via WDI pin or write answer to specified register periodically. When operating in NORMAL state, the device will go to RESET state once reset event occurs.

RESET State

All outputs keep on in this state, the device will transit from NORMAL state to RESET state when any of below reset event occurs:

- VOUT1's output is out of OV/UV protection range
- VOUT2's output is out of OV/UV protection range
- VOUT3's output is out of OV/UV protection range
- VOUT4's output is out of OV/UV protection range
- Watchdog Failure

When the device enters RESET state, the RESETB pin will assert for a holding time. The device will go back to NORMAL state automatically once the holding time is expired and no reset event, which can be configured in register **CONFIG_T1** via I2C. Upon entering NORMAL state Watchdog failure counter will be reset and start running again. Then MCU should feed the watchdog again.

VIN and EN UVLO

When the VIN pin voltage rises above 3.2V and the EN pin voltage exceeds the enable threshold of 1.2V, the device is enabled. And the device disables when the VIN pin voltage falls below 2.8V or when the EN pin voltage is below 1.0V.

EN pin is connected internally to ground allows the device to be disabled when EN pin is floating to simplify the system design.

High Efficiency Regulators

The switching frequency of HV Buck is 2.2MHz/400kHz selectable. All the LV bucks employ 2.2MHz fixed frequency peak current mode control. Forced continuous conduction mode (FCCM) allows the device to have a high output performance when light load. Built-in UVLO ensures all channels are capable of regulated output under the operating VIN range. Soft-start is fixed at 1ms for all channels. VOUT1 will always be the firstly built rail after power on, the other rails can be configured with range 0ms to 75ms turn on delay. Then the device can achieve a variety of sequence to fit power system.

The VOUT1 is a HV synchronous buck converter directly power from VIN pin. It's regulated at 3.3V with up to 3A continuous current. An external 100nF ceramic bootstrap capacitor between BST and SW1 pin powers high-side power MOSFET gate driver. The bootstrap capacitor voltage is charged from an integrated voltage regulator when high-side power MOSFET is off and low-side power MOSFET is on. Note VOUT1 is the power supply for VOUT2/3/4.

The VOUT2 and VOUT3 are two identical LV synchronous buck converter power by VOUT1. Their output can be configured via I2C range from 0.8V to 2.35V with 50mV step. Each is capable of 2A continuous current. To further improve the EMI performance, the VOUT2 and VOUT3 will operate with 180° phase-shifted clock.

The VOUT4 is a low-drop regulator(LDO) also powered by VOUT1. The LDO output is factory-programmed at 1.8V, 2.7V, 2.8V, 2.9V or 3.3V with up to 400mA continuous output current.

The converters have proprietary designed gate driver scheme to resist switching node ringing without sacrificing MOSFET turn-on and turn-off time, which further erases high frequency radiation EMI noise caused by the MOSFETs hard switching.

Each output voltage is continuously monitored during operation, the OV/UV threshold can be adjusted independently in register **CONFIG_PGSEL1** and **CONFIG_PGSEL2**.

Deep Over Voltage Protection

If any output exceeds the deep over voltage protection threshold 115%, all outputs will shut off for the hiccup time. When hiccup ends, the normal power up sequence will start again following turn on delay setting in register. When entry hiccup, the output discharge will operate during the hiccup time. The threshold can be configured by bits **DEEP_OVP_SEL[1:0]**.

Deep Under Voltage Protection

If an output falls below the deep under voltage protection threshold 75%, all outputs will shut off for the hiccup time. When hiccup ends, the normal power up sequence will start again following turn on delay setting in register. When entry hiccup, the output discharge will operate during the hiccup time. The threshold can be configured by bits **DEEP_UVP_SEL[1:0]**.

Thermal Shutdown

The

pseudo modulation. Therefore, the SCT61441S can guarantee that the switching frequency does not drop into the 1.8MHz AM band limit.

Frequency Foldback

To avoid meeting minimum on time, the HV buck VOUT1 will reduce switching frequency actively when input voltage rising high. Other channel's frequency is unchanged. When VIN greatly drops and minimum off time of HV buck VOUT1 is kicked, the VOUT1 enter dropout mode and also reduce its frequency to get max output.

RESETB Indicator

The RESETB indicator will assert when reset event occurs. It will reset MCU if it fails to feed watchdog, MCU then can reloading program to ensure the program run well. The RESETB pin is an open-drain output and can be connected to various I/O level through pull-up resistor. The reset event mapping to RESETB pin can be configured through changing the register **RSTMAP**.

Active Output Discharge

Once any output is shutoff due to deep safe events or disabled by I2C command, there is an active output discharge path will be turned on for each channel.

Synchronization and Watchdog Disable

The device can be synchronized to an external clock when GPIO pin is set to SYNC. The external clock must be connected between the GPIO pin and ground. The synchronization frequency range is from 1.5MHz to 3MHz. A square wave clock signal to GPIO pin must have high level no lower than 1.2V, low level no higher than 0.6V, and pulse width larger than 15ns.

When GPIO pin is set to WDDIS, if a high level on GPIO pin stays longer than 20μs, the watchdog will be disabled. Only when connecting low level to GPIO pin can release the watchdog, there is an internal 1.8k pull-down resistor.

Watchdog

During NORMAL state, the watchdog can monitor the MCU with programmable cycle. Everytime the device enters NORMAL state and RESETB pin is released, the watchdog will be activated if WDDIS pin is low and bit **WD_EN[0]**=1b. There will be extension cycles if **WD_EN[0]**=1b when entering NORMAL state, which is used to wait MCU's program loading process and can be configured by bit **WD_1UD[2:0]**. During the close window of first update extension, any WDI or **WD_KEY** signals will be ignored and WD error counter keeps zero.

Simple Watchdog

If **WD_MODE[0]** = 1, the device will implement simple watchdog, the MCU should provide trigger pulse to WDI pin or write any byte to specific register **WD_KEY** within the open window. The length of open window and closed window can be configured by I2C. A correct watchdog trigger will restart the whole window cycle immediately. Giving pulse or writing byte to register **WD_KEY** during the closed window will result in **WD_UV[0]** violation and will restart the whole window cycle immediately. If MCU doesn't send high pulse or write byte to **WD_KEY** before the whole window is expired, **WD_EXP[0]** violation occurs. Any violation will make the WD error counter plus one. When WD error counter reaches the **WD_FAIL_CNT[0]** (1 or 2 times), a WD Failure is reported and device enters RESET state.

QA Watchdog

If **WD_MODE[0]** = 0, the device will implement Question and Answer (QA) watchdog and signals on WDI pin are ignored. In QA watchdog mode, MCU should read register **WD_KEY** to get the answer through I2C. Then MCU response the watchdog in open window through writing the specific answer to register **WD_KEY**. A correct watchdog trigger will refresh the whole window cycle immediately and the **WD_KEY** register being updated. Writing the incorrect answer to the **WD_KEY** will result in the value written being ignored and a **WD_LFSR[0]** violation. Writing the correct response during a closed window will result in the write being ignored and a **WD_UV[0]** violation. If MCU doesn't write byte to **WD_KEY** and the whole window is expired, **WD_EXP[0]** violation occurs. LFSR

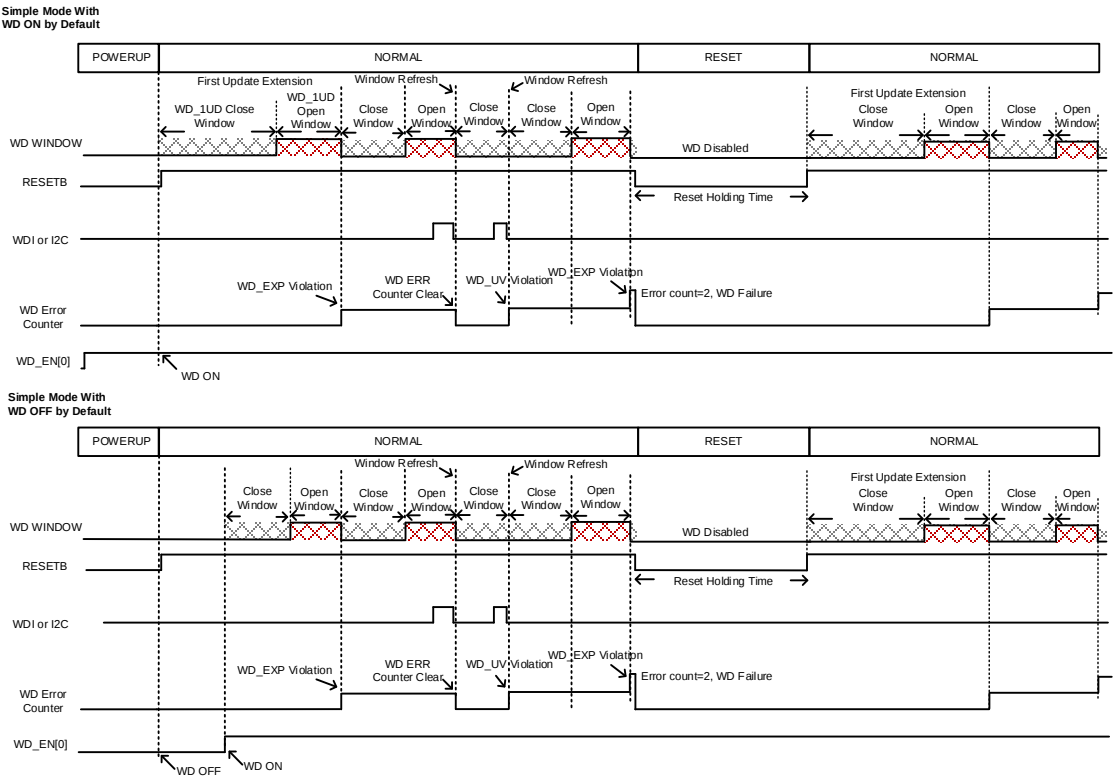
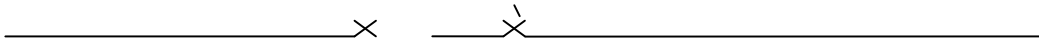


Figure 3a. Simple Watchdog Error Timing



I2C Interface

The SCT61441S integrates a two-wire serial interface for bidirectional communications between the device and the master through bus. The I2C protocol defines two bus lines, the serial data line (SDA) and the serial clock line (SCL). The SCT61441S is always assigned a unique chip address and operates as a slaver, the master drives the SCL line and transfer bidirectional data through SDA line. Both the SCL and SDA lines need a pull-up resistor connected to bus voltage since HIGH state is the default state when bus is idle. The SCT61441S supports Standard-mode (up to 100 kHz), Fast-mode (up to 400 kHz), Fast-mode Plus (up to 1 MHz). The internal filtering ignores spikes and noises on the bus line to preserve data integrity. The maximum capacitive load for each bus line is given in Electrical Characteristic thus the number of interfaces is limited.

Data Validity

The data on the SDA line must be stable during the HIGH period of the clock. The HIGH or LOW state of the data line can only change when the clock signal on the SCL line is LOW.

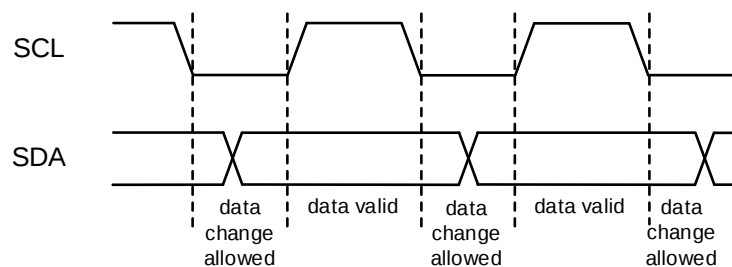


Figure 4. Data Validity Diagram

START and STOP Conditions

The data transfer always generates START and STOP conditions to announce the process. A HIGH to LOW transition on the SDA line while SCL is HIGH defines a START condition. A LOW to HIGH transition on the SDA line while SCL is HIGH defines a STOP condition. Both the START and STOP conditions are generated by master on bus.

The bus is considered to be busy after START condition and released after STOP condition. A repeated START condition during transmission is also valid and will be regard as a new START condition.

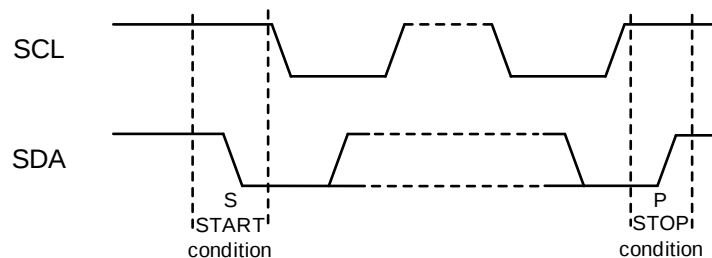


Figure 5

Packet Error Checking (PEC)

The SCT61441S supports optional packet error checking (PEC) byte during the I2C communication. PEC can significantly increase fault coverage on the I2C interface. The PEC byte is implemented through CRC-8 polynomial of $x^8 + x^2 + x + 1$. The PEC byte does not take ACK, NACK, START, STOP, Repeated START bits into calculation. The PEC byte is calculated on the register address and data byte over the entire message from the first START condition, note that the slave address is removed both in write and read command. When PEC is enabled, the device will reject the write command if the master send an incorrect PEC byte. When in read mode with PEC enabled, the master should acknowledge the data byte thus then the device will send the PEC byte. The PEC can be configured by **PEC_EN** in register **CONFIG_FSS**.

Write Data Format

A write to the device includes transmission of the following:

- START condition
- Slave address with the write bit set to 0
- 1 byte of data to register address
- 1 byte of data to the command register
- STOP condition

Read Data Format

A read from the device includes the following:

- Transmission of a START condition
- Slave address with the write bit set to 0
- 1 byte of data to register address
- Restart condition
- Slave address with read bit set to 1
- 1 byte of data to the command register
- STOP condition

Figure 6 illustrates the proper format for one frame.

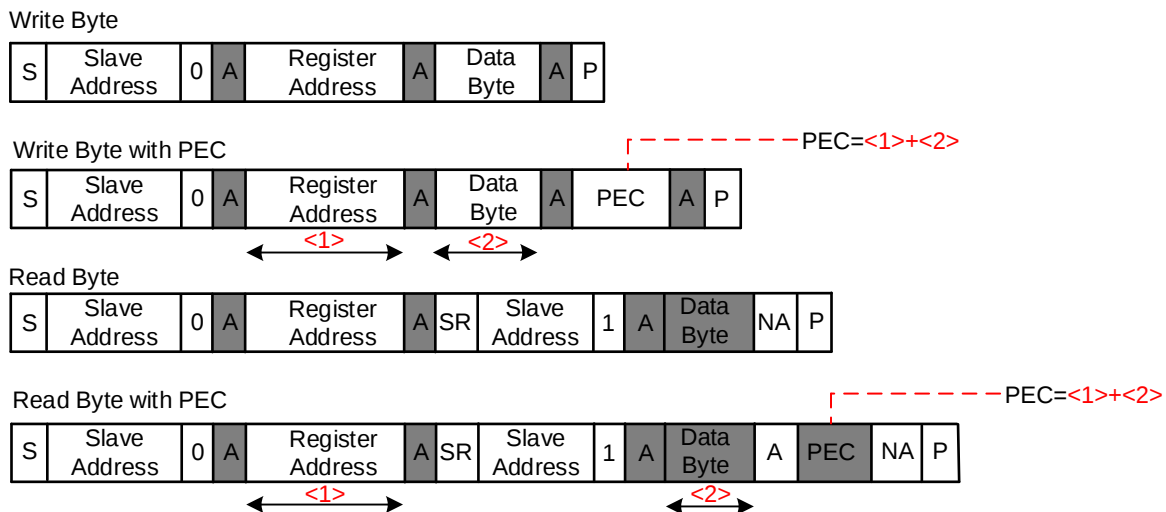


Figure 6. Transmission Data Format Diagram

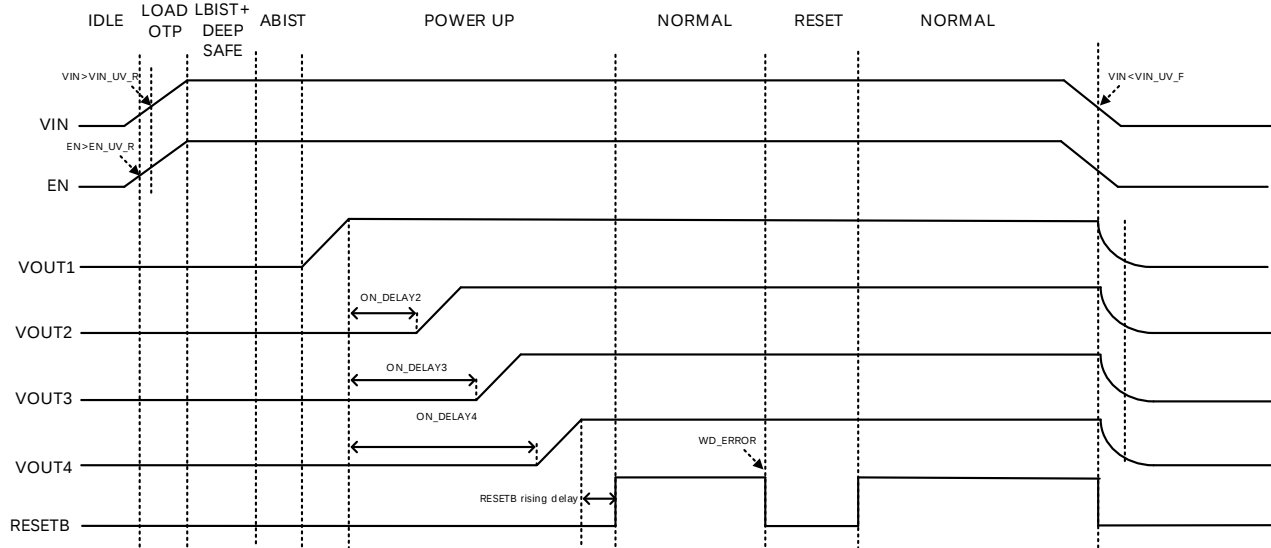


Figure 7. Power on Sequence

Typical Application

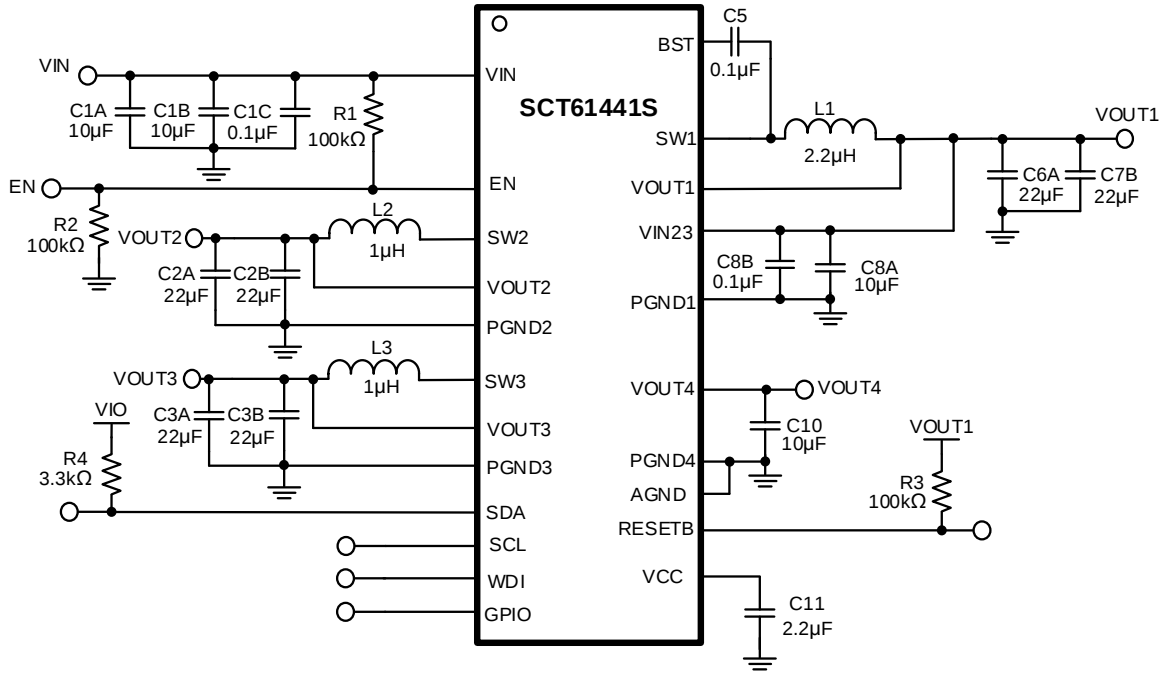


Figure 8. Application Schematic, 3.5V to 36V, PMIC Regulator at 2.2MHz

Design Parameters

Design Parameters	Example Value
Input Voltage	12V Normal 3.5V to 36V
Output Voltage	VOUT1: 3.3V VOUT2: 1.2V VOUT3: 1.8V VOUT4: 2.8V
Maximum Output Current	VOUT1: 3A (in total) VOUT2: 2A VOUT3: 2A VOUT4: 400mA
Switching Frequency	2.2MHz
Output Voltage Ripple (peak to peak)	VOUT1: 10mV VOUT2: 5mV VOUT3: 5mV

Under Voltage Lock-Out

An external voltage divider network of R_1 from the input to EN pin and R_2 from EN pin to the ground can set a higher input voltage's Under Voltage Lock-Out (UVLO) threshold. The UVLO has two thresholds]O 0 1 64n6 (U)-1.f(o)0.53 ()0.6 (V)

The total current flowing through the inductor is the inductor ripple current plus the output current. When selecting an inductor, choose its rated current especially the saturation current larger than its peak operation current and RMS current also not be exceeded. Therefore, the peak switching current of inductor, I_{LPEAK} and I_{LRMS} can be calculated as in equation 5 and equation 6.

$$= \frac{I_{LPP}}{2} + I_{OUT} \quad (5)$$

$$= \sqrt{\left(\frac{I_{LPP}}{2}\right)^2 + \frac{1}{12} I_{LPP}^2} \quad (6)$$

Where

- I_{LPEAK} is the inductor peak current
- I_{OUT} is the DC load current
- I_{LPP} is the inductor peak-to-peak current
- I_{LRMS} is the inductor RMS current

In overloading or load transient conditions, the inductor peak current can increase up to the switch current limit of the device. The most conservative approach is to choose an inductor with a saturation current rating greater than peak current limit. Because of the maximum I_{LPEAK} limited by device, the maximum output current that the device can deliver also depends on the inductor current ripple. Thus, the maximum desired output current also affects the selection of inductance. The smaller inductor results in larger inductor current ripple leading to a lower maximum output current.

Input Capacitor Selection

The input current to the step-down DCDC converter is discontinuous, therefore it requires a capacitor to supply the AC current to the step-down DCDC converter while maintaining the DC input voltage. Use capacitors with low ESR for better performance. Ceramic capacitors with X5R or X7R dielectrics are usually suggested because of their low ESR and small temperature coefficients, and it is strongly recommended to use another lower value capacitor (e.g. 0.1uF) with small package size (0603) to filter high frequency switching noise. Place the small size capacitor as close to VIN and GND pins as possible.

For buck converter, the voltage rating of the input capacitor must be greater than the maximum input voltage. And the capacitor must also have a ripple current rating greater than the maximum input current ripple. The RMS current in the input capacitor can be calculated using Equation 7.

$$= I_{OUT} \sqrt{1 - \frac{V_{OUT}}{V_{IN}}} \quad (7)$$

The worst case condition occurs at $V_{IN}=2*V_{OUT}$, where:

$$= 0.5 \quad (8)$$

For simplification, choose an input capacitor with an RMS current rating greater than half of the maximum load current.

When selecting ceramic capacitors, it needs to consider the effective value of a capacitor decreasing as the DC bias voltage across a capacitor increasing.

The input capacitance value determines the input ripple voltage of the regulator. The input voltage ripple can be calculated using Equation 9 and the maximum input voltage ripple occurs at 50% duty cycle.

$$\Delta V_{IN} = \frac{I_{OUT}}{C_{IN}} \left(1 - \frac{V_{OUT}}{V_{IN}}\right) \quad (9)$$

Bootstrap Capacitor Selection

ST pin and SW1 pin for proper operation. A ceramic capacitor with X5R or better grade dielectric is recommended. The capacitor should have a 10V or higher voltage rating.

Output Capacitor Selection

The selection of output capacitor will affect output voltage ripple in steady state and load transient performance.

For buck converter, the output ripple is essentially composed of two parts. One is caused by the inductor current ripple going through the Equivalent Series Resistance ESR of the output capacitors and the other is caused by the inductor current ripple charging and discharging the output capacitors. To achieve small output voltage ripple, choose a low-ESR output capacitor like ceramic capacitor. For ceramic capacitors, the capacitance dominates the output ripple. For simplification, the output voltage ripple can be estimated by Equation 10 desired.

$$\Delta V_{OUT_BUCK} = \frac{(V_{IN} - V_{OUT})}{8 f_{SW} L C_{OUT}} \quad (10)$$

Where

- ΔV_{OUT_BUCK} is the output voltage ripple of buck converter
- f_{SW} is the switching frequency
- L is the inductance of inductor
- C_{OUT} is the output capacitance
- V_{OUT} is the output voltage
- V_{IN} is the input voltage

Due to capacitor's degrading under DC bias, the bias voltage can significantly reduce capacitance. Ceramic capacitors can lose most of their capacitance at rated voltage. Therefore, leave margin on the voltage rating to ensure adequate effective capacitance. Typically, two 10

Table 3. Recommended BOM for Typical Application

Output Rail	Frequency (MHz)	L (uH)	Input Capacitor (uF)	Output Capacitor (uF)
Buck1	2.2	2.2	2 x 10+1 x 0.1	2 x 22
Buck2	2.2	1	10+1 x 0.1	2 x 22
Buck3	2.2	1		2k3

Application Waveforms

$V_{in}=12V$, $V_{OUT1}=3.3V$, $V_{OUT2}=1.1V$, $V_{OUT3}=1.5V$, $V_{OUT4}=2.8V$, unless otherwise noted

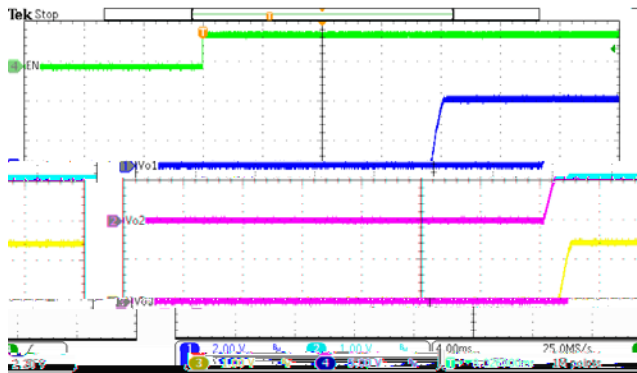


Figure 10. EN On

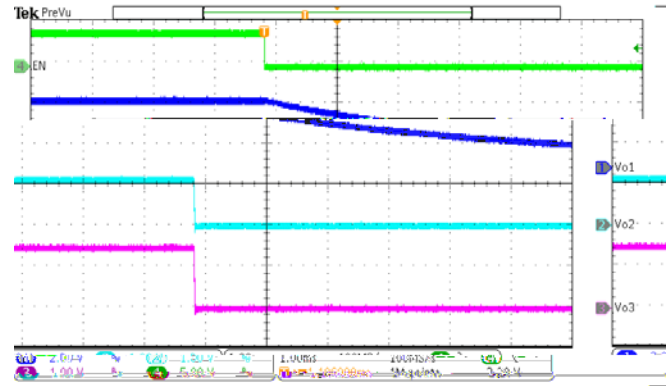


Figure 11. EN Off

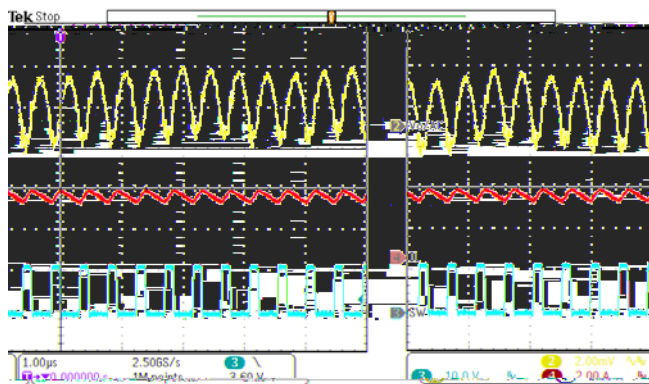


Figure 12. Buck1 Steady State ($I_{o1} = 3A$)

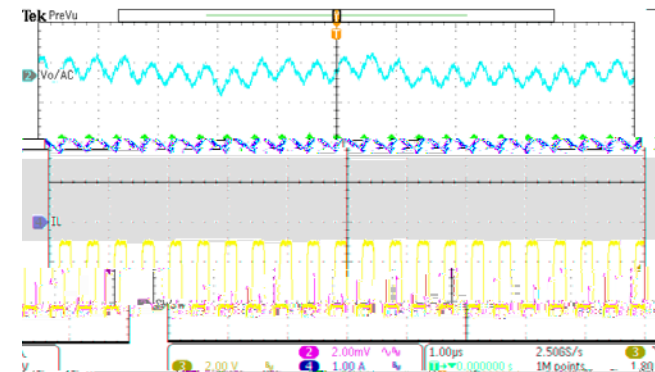


Figure 13. Buck2 Steady State ($I_{o2} = 2A$)

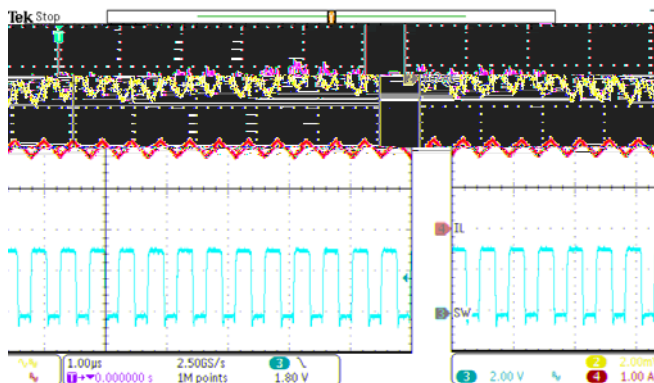


Figure 14. Buck3 Steady State ($I_{o3} = 2A$)

Layout Guideline

Proper PCB layout is a critical for device's stable and efficient operation. The traces conducting fast switching currents or voltages are easy to interact with stray inductance and parasitic capacitance to generate noise and degrade performance. For better results, follow these guidelines as below:

1. Power grounding scheme is very critical because of carrying power, thermal, and glitch/bouncing noise associated with clock frequency. The rule of thumb is to make ground trace lowest impedance and power are distributed evenly on PCB. Sufficiently placing ground area will optimize thermal and not causing over heat area.
2. Make sure the ground path between VIN capacitor and PGND1 pin is shortest with lowest impedance.
3. Place a low ESR ceramic capacitor as close to VIN1 and VIN23 pin and the ground as possible to reduce parasitic effect.
4. For operation at full rated load, the top side ground area must provide adequate heat dissipating area. Make sure top switching loop with power have lower impedance of grounding.
5. The bottom layer is a large ground plane connected to the ground plane on top layer by vias. The power pad should be connected to bottom PCB ground planes using multiple vias.
6. Output inductor should be placed close to the SW pin. The switching area of the PCB conductor minimized to prevent excessive capacitive coupling.
7. EN UVLO adjust resistors and feedback trace should connect to small signal ground which must return to the GND pin without any interleaving with power ground.
8. For achieving better thermal performance, a four-layer layout is strongly recommended.

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ADDRESS	REGISTER	DEFAULT VALUE	OTP ACCESS	I2C LOCK	WD LOCK
0x00	CHIPID	-	Y	N	N
0x01	CONFIG_FSS	00h	Y	Y	N
0x02	CONFIG_T1	02h	Y	Y	N
0x03	CONFIG_T2	00h	Y	Y	N
0x05	CONFIG_EN	1Eh	Y	Y	N
0x06	CONFIG_PU1	43h	Y	Y	N

CHIPID [7:0]				
ADDRESS: 0x00				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	RESERVED	R	/	Reserved, always read as 01b
[5:0]	CONFIG_ID	W/R	Chip Configuration Identification. This is a unique number identifying the factory configuration of the device. This helps identify/verify the configuration without having to look at all configuration registers.	See Ordering Information

CONFIG_FSS [7:0]				
ADDRESS: 0x01				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7]	EN_HOLD	W/R	Enable Hold. Overrides the EN pin to keep the device enabled. This bit is cleared when RESETB is asserted.	0 = EN pin controls power down 1 = Device enabled. Ignores EN pin state
[6]	FSS_EN	W/R	Frequency Spread Spectrum Enable.	0 = Disabled 1 = Enabled
[5]	FSS_MODE	W/R	Frequency Spread Spectrum Mode.	0 = Pseudorandom Modulation 1 = Triangle Modulation
[4]	FSS_PERIOD	W/R	Frequency Spread Period.	0 = 4.5KHz 1 = 10KHz
[3:2]	FSS_RANGE	W/R	Frequency Spread Spectrum Range.	00 = $\pm 5\%$; 01 = $\pm 2.5\%$; 10 = $\pm 7.5\%$; 11 = $\pm 3.75\%$
[1]	PMIC_RESET_EN	W/R	Enable PMIC reset Function. After this bit is set to 1, writing EN_ALL[0]=0 will shut down all power channels, reset all registers and restart automatically.	0 = Disabled 1 = Enabled
[0]	PEC_EN	W/R	Packet Error Checking Enable. Set this bit to a 1 to enable PEC or 0 to disable PEC.	0 = Disabled 1 = Enabled

CONFIG_T1 [7:0]				
ADDRESS: 0x02				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	RESETB_HT	W/R	RESETB Hold Time Selection. This is the least amount of time that the RESET pin is active (low) after entering RESET state.	00 = 10ms; 01 = 20ms; 10 = 30ms; 11 = 40ms
[5:4]	RESETB_DLYR	W/R	RESETB Rising delay when state change from POWERUP to NORMAL	00 = 2.5ms; 01 = 5ms; 10 = 7.5ms; 11 = 10ms
[3:2]	RESERVED	R	/	/
[1:0]	DELAY_SCALE	W/R	Power up and Recover On Delay Scale.	00: Scale=0.5ms. Delay ranges from 0~7.5ms 01: Scale =1ms. Delay ranges from 0-15ms

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				10: Scale=2.5ms. Delay ranges from 0-37.5ms 11: Scale =5ms. Delay ranges from 0-75ms
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CONFIG_T2 [7:0]				
ADDRESS: 0x03				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	RESERVED	R	/	/

[7:4]	ON_DELAY3	W/R	OUT3 Power-Up and Recover Turn On delay.	when DELAY_SCALE=00, $t_{ON_DELAY3} = ON_DELAY3[3:0] \times 0.5ms$ when DELAY_SCALE=01, $t_{ON_DELAY3} = ON_DELAY3[3:0] \times 1ms$ when DELAY_SCALE=10, $t_{ON_DELAY3} = ON_DELAY3[3:0] \times 2.5ms$ when DELAY_SCALE=11, $t_{ON_DELAY3} = ON_DELAY3[3:0] \times 5ms$
[3:0]	ON_DELAY2	W/R	OUT2 Power-Up and Recover Turn On delay.	when DELAY_SCALE=00, $t_{ON_DELAY2} = ON_DELAY2[3:0] \times 0.5ms$ when DELAY_SCALE=01, $t_{ON_DELAY2} = ON_DELAY2[3:0] \times 1ms$ when DELAY_SCALE=10, $t_{ON_DELAY2} = ON_DELAY2[3:0] \times 2.5ms$ when DELAY_SCALE=11, $t_{ON_DELAY2} = ON_DELAY2[3:0] \times 5ms$

RSTMAP

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[5]	UV_WAR4	Read Clear	UV warning for OUT4, Digital Filter is not included	0 = OUT4 is above UV threshold before DF 1 = OUT4 is below UV threshold before DF
[4]	RESERVED	R	/	/
[3]	UV_WAR3	Read Clear	UV warning for OUT3, Digital Filter is not included	0 = OUT3 is above UV threshold before DF 1 = OUT3 is below UV threshold before DF
[2]	UV_WAR2	Read Clear	UV warning for OUT2, Digital Filter is not included	0 = OUT2 is above UV threshold before DF 1 = OUT2 is below UV threshold before DF
[1]	UV_WAR1	Read Clear	UV warning for OUT1, Digital Filter is not included	0 = OUT1 is above UV threshold before DF 1 = OUT1 is below UV threshold before DF
[0]	RESERVED	R	/	/

STATOV [7:0]

ADDRESS: 0x0B

BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7]	OV	Read Clear	OV Comparator Status for all channels with Digital Filter.	0 = All enabled channels are below OV threshold after DF 1 = Any enabled channel is above OV threshold after DF
[6]	RESERVED	R	/	/
[5]	OV_WAR4	Read Clear	OV warning for OUT4, Digital Filter is not included	0 = OUT4 is below OV threshold before DF 1 = OUT4 is above OV threshold before DF
[4]	RESERVED	R	/	/

[3]	OV_WAR3	Read Clear	OV warning for OUT3, Digital Filter is not included	0 = OUT3 is below OV threshold before DF 1 = OUT3 is above OV threshold before DF , Digital Filter
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[5]	OFF4	Read Clear	OFF Comparator Status for OUT4	0 = OUT4 is above OFF threshold 1 = OUT4 is below OFF threshold
[4]	RESERVED	R	/	/
[3]	OFF3	Read Clear	OFF Comparator Status for OUT3	0 = OUT3 is above OFF threshold 1 = OUT3 is below OFF threshold
[2]	OFF2	Read Clear	OFF Comparator Status for OUT2	0 = OUT2 is above OFF threshold 1 = OUT2 is below OFF threshold
[1]	OFF1	Read Clear	OFF Comparator Status for OUT1	0 = OUT1 is above OFF threshold 1 = OUT1 is below OFF threshold
[0]	RESERVED	R	/	/

STATD [7:0]				
ADDRESS: 0x0D				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7]	RESERVED	R	/	/
[6]	CLK_ERR	Read Clear	CLK fault indicator	0 = No fault detected 1 = CLK error detected
[5]	SUP_ERR	Read Clear	Supply fault indicator, include VCC OV fault and VIN OV fault	0 = No fault detected 1 = VCC OV or VIN OV detected
[4]	RST_ENTER	Read Clear	RESET state indicator	0 = No fault detected 1 = RESET state has entered since the last read.
[3]	DEEPSAFE_ENTER	Read Clear	DEEPSAFE state indicator	0 = No fault detected 1 = DEEPSAFE state has entered since the last read.
[2]	PIN_ERR	Read Clear	Pin fault indicator, include RESETB Pin stuck fault and GND pin LOSS fault	0 = No fault detected 1 = RESETB Short to supply detected or pull-down fail or GND LOSS since the last read
[1]	THSD	Read Clear	Thermal Shutdown Indication	0 = No thermal shutdown 1 = Thermal shutdown has occurred since last read
[0]	INTERR	Read Clear	Internal Error, include OTP CRC failure, LBIST and ABIST failure	0 = No internal error detected 1 = Internal error detected

STATWD [7:0]				
ADDRESS: 0x0E				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	RESERVED	R	/	/
[5]	RESETB_STAT	R	RESETB Pin State. Allows verification of the state of the RESETB pin. This is the real-time RESETB pin state.	0 = RESETB is low 1 = RESETB is high
[4]	WD_OPEN	R	Watchdog Open Window. This bit indicates that it is permissible to update the watchdog. This bit shows real-time status.	0 = Watchdog update not open 1 = Watchdog ok to update
[3]	WD_ERR	R	Watchdog ERROR for 1 time or 2 times (config by WD_FAIL_CNT), LFSR mismatch is not included	0 = No error detected 1 = Error detected

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[2]	WD_LFSR	Read Clear	LFSR Write Mismatch. The MCU/SoC did not write the correct value to the WDKEY register.	0 = LFSR key match 1 = LFSR key mismatch since last read
[1]	WD_UV	Read Clear	Watchdog Update Violation. The MCU/SoC wrote to the WDKEY register during the CLOSE window.	0 = No violation detected 1 = Watchdog updated too early
[0]	WD_EXP	Read Clear	Watchdog Open Window Expired. The MCU/SoC did not write to the WDKEY register during the whole window.	0 = Watchdog timer not expired 1 = Watchdog timer expired

VOUT2 [7:0]

ADDRESS: 0x0F

BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:5]	RESERVED	R	/	/
[4:0]	OUT2	W/R	OUT2 Voltage Setting	VOUT2 = OUT2[4:0] x 50mV + 0.8V (0.8V to 2.35V)

VOUT3 [7:0]

ADDRESS: 0x10

BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:5]	RESERVED	R	/	/
[4:0]	OUT3	W/R	OUT3 Voltage Setting	VOUT3 = OUT3[4:0] x 50mV + 0.8V (0.8V to 2.35V)

CONFIG_MISC [7:0]

ADDRESS: 0x11

BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	GPIO_SEL	W/R	GPIO pin function, and this bit is invalid when changed online.	00 = Reserved 01 = WDDIS (input) 10 = SYNC (input) 11 = Reserved
[5]	RESERVED	R	/	/
[4]	VIN_OVP_EN	W/R	Enable of VIN OVP. When VIN>43V, part enter DEEPSAFE mode.	0 = Disabled 1 = Enabled
[3:2]	VIN_START	W/R	VIN start threshold at VIN rising	00 = 3.2V; 01 = 4V; 10 = 5V; 11 = 6V
[1:0]	VIN_STOP	W/R	VIN stop threshold at VIN falling	00 = 2.8V; 01 = 3.5V; 10 = 4.5V; 11 = 5.5V

CONFIG_PFM [7:0]

ADDRESS: 0x12

BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:3]	RESERVED	R	/	/
[2]	PFM3	W/R	BUCK3 FCCM/PFM mode selection when NORMAL mode.	0 = FCCM 1 = PFM
[1]	PFM2	W/R	BUCK2 FCCM/PFM mode selection when NORMAL mode.	0 = FCCM 1 = PFM
[0]	PFM1	W/R	BUCK1 FCCM/PFM mode selection when NORMAL mode.	0 = FCCM 1 = PFM

CONFIG_WD1 [7:0]				
ADDRESS: 0x13				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7]	WD_MODE	W/R	Simple Windowed Watchdog Enable	0 = QA watchdog enabled 1 = Simple watchdog enabled
[6]	WD_SCALE	W/R	Watchdog Clock Divider Scale	0 = 128μs 1 = 128μs x 64

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				If configured as a QA watchdog, writing the incorrect response to the WDKEY register will result in the value written being ignored and a WD_LFSR violation. Writing the correct response in QA mode during an open window will result in a refresh and the WDKEY register being updated. Writing the correct response in QA mode during a closed window will result in the write being ignored and a WD_UV violation. LFSR polynomial: $x^8 + x^6 + x^5 + x^4 + 1$
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WD_LOCK [7:0]				
ADDRESS: 0x17				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:1]	RESERVED	R	/	/
[0]	WDLOCK	W/R	Watchdog Lock Protection	0 = Watchdog configuration registers are writeable 1 = Watchdog configuration registers are read-only

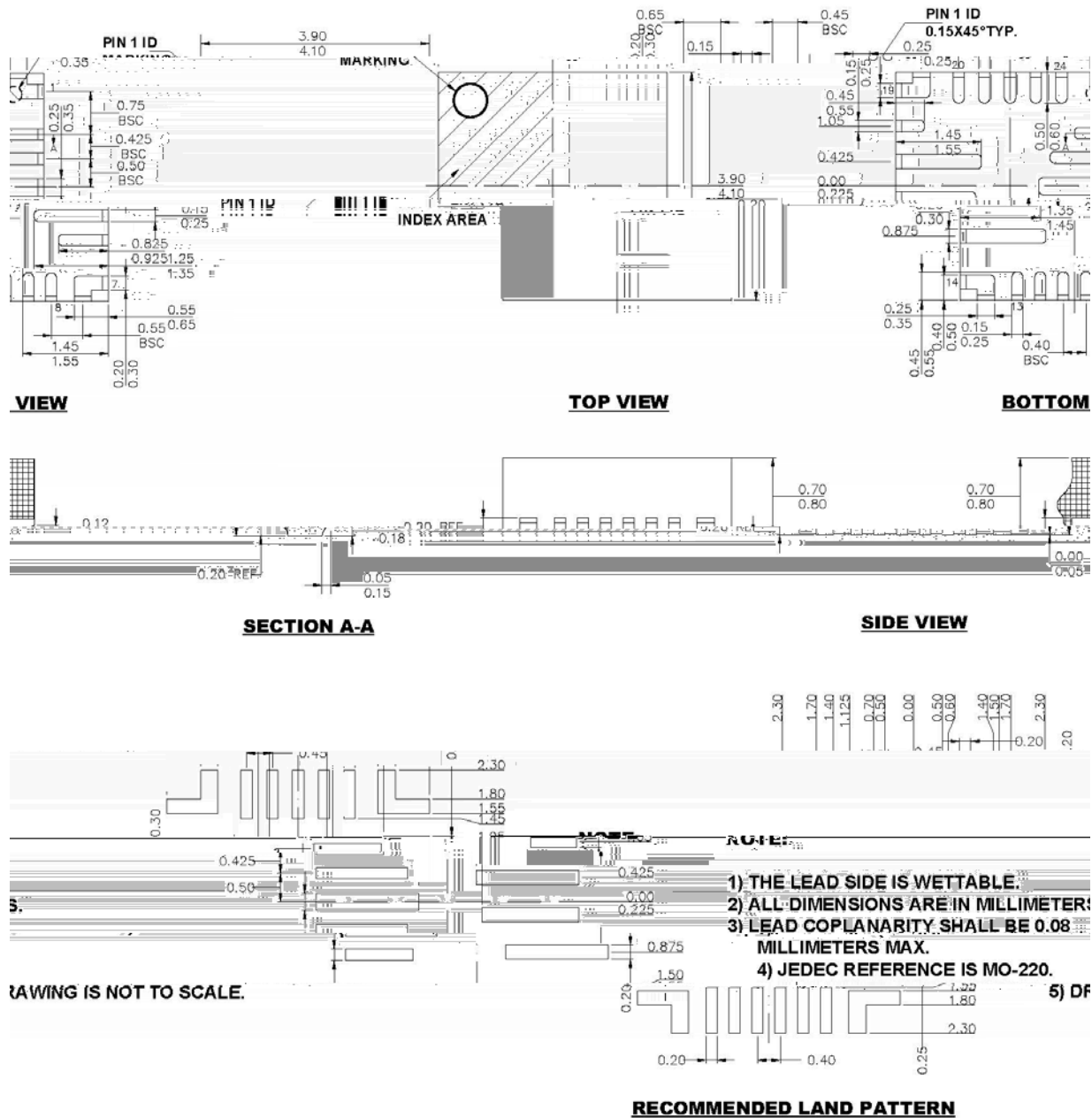
CONFIG_PGSEL1 [7:0]				
ADDRESS: 0x19				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	DEEP_OVP_SEL	W/R	Deep OVP threshold selection for all channels.	00 = +15%; 10 = +10%, others are reserved
[5:4]	DEEP_UVP_SEL	W/R	Deep UVP threshold selection for all channels.	00 = -25%; 01 = -20%; 10 = -15%; 11 = -10%
[3:2]	RESERVED	R	/	/
[1:0]	PG4_SEL	W/R	OUT4 OV/UV threshold selection.	00 = Reserved; 01 = $\pm 6\%$; 10 = $\pm 8\%$; 11 = $\pm 10\%$

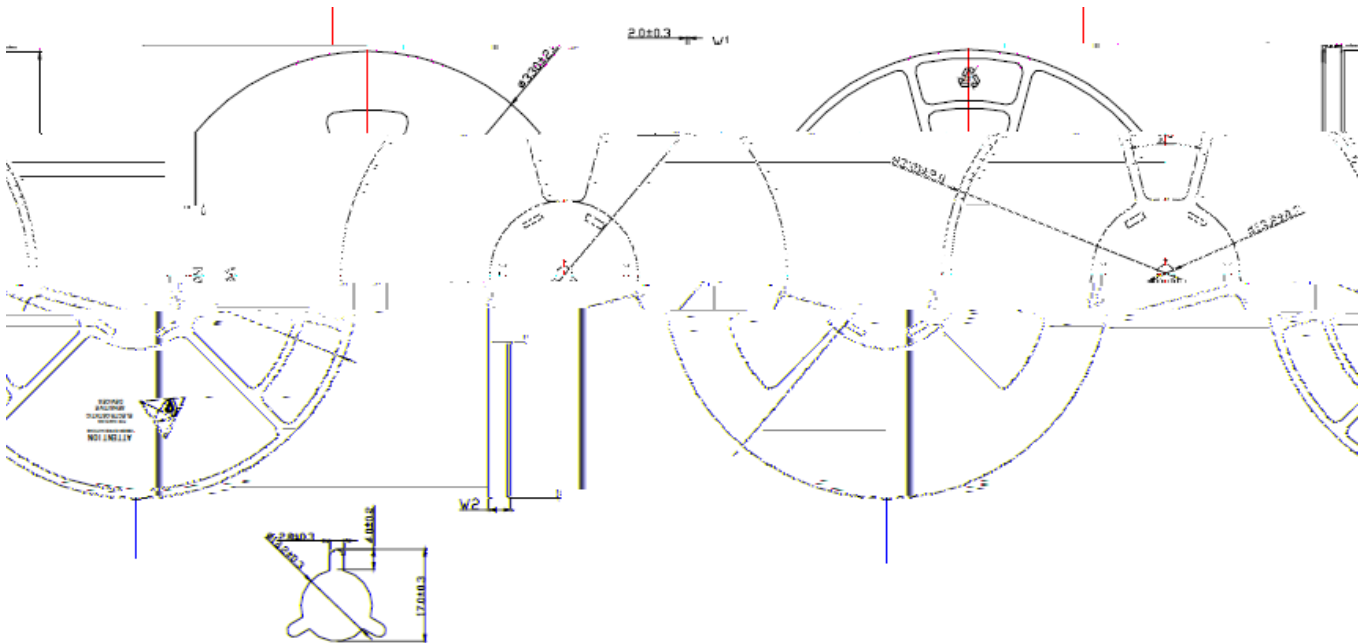
CONFIG_PGSEL2 [7:0]				
ADDRESS: 0x1A				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:6]	RESERVED	R	/	/
[5:4]	PG3_SEL	W/R	OUT3 OV/UV threshold selection.	00 = Reserved; 01 = $\pm 6\%$; 10 = $\pm 8\%$; 11 = $\pm 10\%$
[3:2]	PG2_SEL	W/R	OUT2 OV/UV threshold selection.	00 = Reserved; 01 = $\pm 6\%$; 10 = $\pm 8\%$; 11 = $\pm 10\%$
[1:0]	PG1_SEL	W/R	OUT1 OV/UV threshold selection.	00 = Reserved; 01 = $\pm 6\%$; 10 = $\pm 8\%$; 11 = $\pm 10\%$

I2C_LOCK [7:0]				
ADDRESS: 0x1C				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7:1]	RESERVED	R	/	/

[0]	I2C_LOCK	W/R	Lock Protection. If 0 by default, then this bit can be changed through the I2C.	0 = All registers can be written. 1 = Writes are ignored to protected registers.
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SYS_STATE [7:0]				
ADDRESS: 0x22				
BITS	FIELD	TYPE	DESCRIPTION	DECODE
[7]	OTP_CRC_ERR	R	when OTP CRC has error, this bit=1	0 = pass 1 = fail
[6]	RESERVED	R	/	/
[5]	LBIST_ERR	R	when LBIST has error, this bit=1	0 = pass 1 = fail
[4]	RESERVED	R	/	/
[3:0]	SYS_STATE	R	System state machine.	0000 = IDLE, 0001 = LBIST, 0010 = DEEPSAFE, 0011 = LOADOTP, 0101 = NORMAL, 0110 = ABIST, 0111 = POWERUP, 1101 = RESET, others are reserved

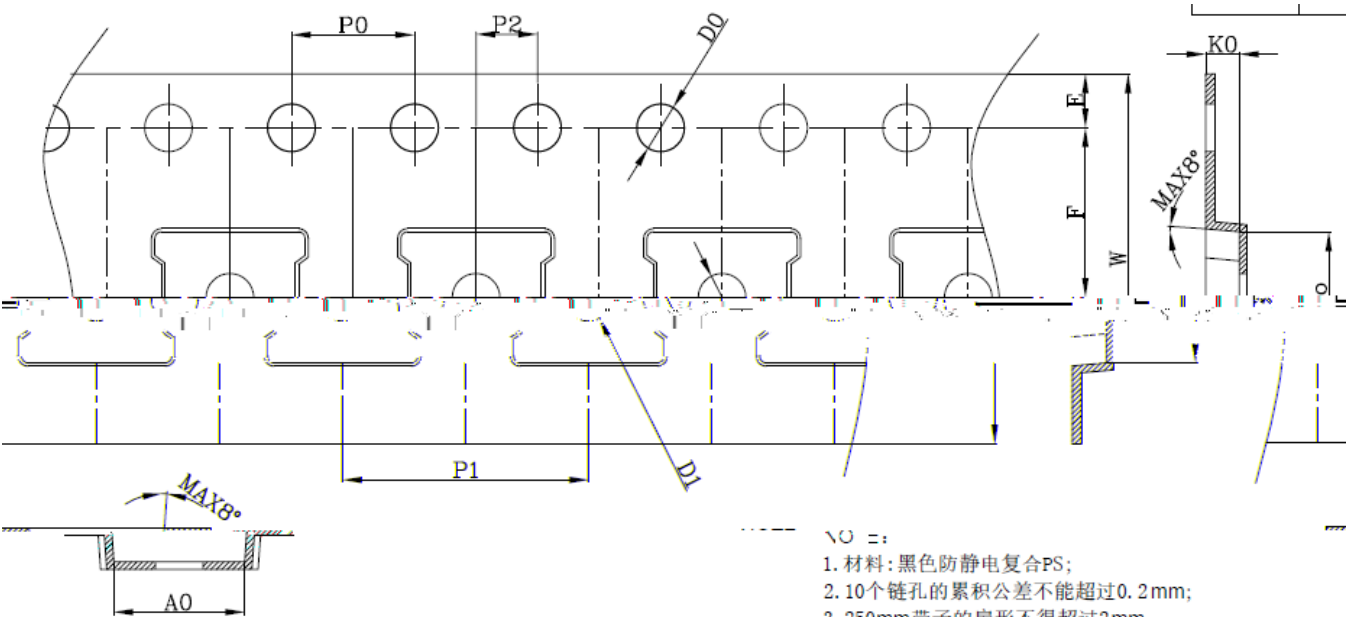




PRODUCT SPECIFICATIONS

TYPE WIDTH	ϕA	ϕN	W1 (Min)	W2 (Max)
12MM	330 ± 2.0	100 ± 1.0	12.4	19.4
16mm	330 ± 2.0	100 ± 1.0	16.4	23.4
24MM	330 ± 2.0	100 ± 1.0	24.4	31.4
32MM	330 ± 2.0	100 ± 1.0	32.4	39.4
44MM	330 ± 2.0	100 ± 1.0	44.4	51.4

SCT61441S



- NO.:
1. 材料: 黑色防静电复合PS;
 2. 10个链孔的累积公差不能超过0.2mm;
 3. 250mm链孔的扁形不得超过2mm;
 4. 所有尺寸符合EIA-401-E的要求.

SYMBOL	A0	R0	K0	P0	P1	P2
.00±0.05	SPEC	4.30±0.10	4.30±0.10	1.10±0.10	1.00±0.10	8.00±0.10
W	SYMBOL	T	E	F	D0	D1
.00±0.30	SPEC	0.30±0.05	1.75±0.10	5.50±0.05	1.55±0.05	1.55±0.10